ACPM-7822

JCDMA 4x4 Power Amplifier Module (898-925MHz)

AVAGO

Data Sheet

Description

The ACPM-7822 is a fully matched 10-pin surface mount module developed for JCDMA. This power amplifier module operates in the 898-925MHz bandwidth. The ACPM-7822 meets stringent CDMA linearity requirements up to 28dBm output power. The 4mmx4mm form factor package is self contained, incorporating 50ohm input and output matching networks

The ACPM-7822 features 5th generation of CoolPAM circuit technology which supports 3 power modes – bypass, mid and high power modes. The CoolPAM is stage bypass technology enhancing PAE (power added efficiency) at low and medium power range. Active bypass feature is added to 5th generation to enhance PAE further at low output range. This helps to extend talk time.

The power amplifier is manufactured on an advanced InGaP HBT (hetero-junction Bipolar Transistor) MMIC (microwave monolithic integrated circuit) technology offering state-of-the-art reliability, temperature stability and ruggedness.

Component Image



Features

- Thin Package (0.9mm typ)
- Excellent Linearity
- 3-mode power control with Vbp and Vmode Bypass / Mid Power Mode / High Power Mode
- High Efficiency at max output power
- 10-pin surface mounting package
- Internal 50ohm matching networks for both RF input and output
- Lead-free, RoHS compliant, Green

Applications

• Digital Japan CDMA Band (3GPP2 Band Class 3)

Ordering Information

Part Number	Number of Devices	Container
ACPM-7822-TR1	1000	178mm (7") Tape/Reel
ACPM-7822-BLK	100	Bulk

Absolute Maximum Ratings

No damage assuming only one parameter is set at limit at a time with all other parameters set at or below nominal value.

Operation of any single parameter outside these conditions with the remaining parameters set at or below nominal values may result in permanent damage.

Description	Min.	Typ.	Max.	Unit
RF Input Power (Pin)		0	10.0	dBm
DC Supply Voltage (Vcc1, Vcc2)	0	3.4	5.0	V
Enable Voltage (Ven)	0	2.6	3.3	V
Mode Control Voltage (Vmode)	0	2.6	3.3	V
Bypass Control (Vbp)	0	2.6	3.3	V
Storage Temperature (Tstg)	-55	25	+125	°C

Recommended Operating Condition

Description		Min.	Тур.	Max.	Unit
DC Supply Voltage (Vcc1, Vcc2)		3.2	3.4	4.2	V
Enable Voltage (Ven)					
_	Low	0	0	0.5	V
	High	1.35	2.6	2.9	V
Mode Control Voltage (Vmode)					
_	Low	0	0	0.5	V
	High	1.35	2.6	2.9	V
Bypass Control Voltage (Vbp)					
	Low	0	0	0.5	V
	High	1.35	2.6	2.9	V
Operating Frequency (fo)		898		925	MHz
Ambient Temperature (Ta)		-30	25	85	°C

Operating Logic Table

Power Mode	Ven	Vbp	Vmode	Pout
High Power Mode	High	High	Low	~ 28 dBm
Mid Power Mode	High	High	High	~ 18 dBm
Bypass Mode	High	Low	Χ	~ 11 dBm
Shut Down Mode	Low	Low	Low	-

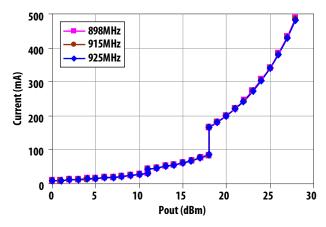
Electrical Characteristics

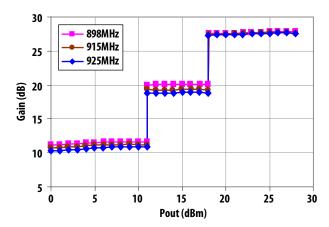
Conditions: Vcc=3.4V, Ven=2.6V, T=25°C, Zin/Zout=50ohm, IS-95 RL, unless otherwise specified.

Characteristics		Condition	Min.	Тур.	Max.	Unit
Operating Frequency Ra	nge		898	-	925	MHz
Gain		High Power Mode, Pout=28dBm	23	28		dB
		Mid Power Mode, Pout=18dBm	13	19		dB
		Bypass Mode, Pout=11dBm	8	11.5		dB
Power Added Efficiency		High Power Mode, Pout=28dBm	35.3	37.7		%
		Mid Power Mode, Pout=18dBm	15.3	22.3		%
		Bypass Mode, Pout=11dBm	8.0	11.9		%
Total Supply Current		High Power Mode, Pout=28dBm		492	525	mA
		Mid Power Mode, Pout=18dBm		82	120	mA
		Bypass Mode, Pout=11dBm		29	43	mA
Quiescent Current		High Power Mode		93	120	mA
		Mid Power Mode		23	30	mA
		Bypass Mode		3	5	mA
Enable Current					100	μΑ
Mode Control Current					100	μΑ
Bypass Control Current					100	μΑ
Total Current in Power-d	own mode	Ven=0V, Vmode=0V, Vbp=0V		0.2	5	μΑ
Adjacent Channel Power Ratio	900 kHz offset 1.98 MHz offset	High Power Mode, Pout=28dBm		-50 -57	-45 -53	dBc dBc
	900 kHz offset 1.98 MHz offset	Mid Power Mode, Pout=18dBm		-51 -64	-46 -54	dBc dBc
	900 kHz offset 1.98 MHz offset	Bypass Mode, Pout=11dBm		-59 -69	-46 -54	dBc dBc
Harmonic Suppression	Second Third	High Power Mode, Pout=28dBm			-30 -40	dBc dBc
Input VSWR		High Power Mode	2:1	2.5:1		
Stability (Spurious Output)		In-Band Load VSWR <= 5:1, All Phase Forwarded Power Fixed, All Power Modes, with Input Filter			-60	dBc
Noise Power in Rx Band ((843-870 MHz)	High Power Mode, Pout=28dBm	High Power Mode, Pout=28dBm			dBm/Hz
Noise Power in GPS Band	d (1575.42 MHz)	High Power Mode, Pout=28dBm	High Power Mode, Pout=28dBm		-141	dBm/Hz
Ruggedness		No Damage Pout<28dBm & Pin<10dBm, All phase High Power Mode			10:1	VSWR

Characteristics Data

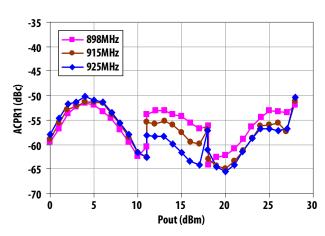
(Vcc=3.4V, Ven=2.6, Vbp, Vmode= 0V or 2.6V, T=25°C, Zin/Zout=50ohm, IS-95 RL)

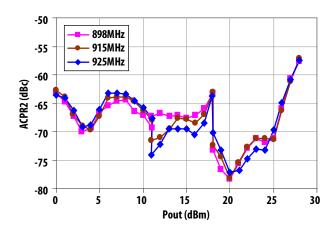




Total Current vs. Output Power

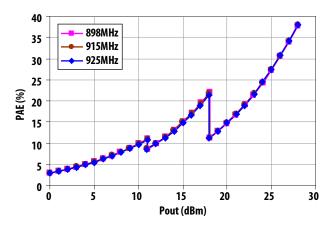
Gain vs. Output Power





Adjacent Channel Power Ratio 1 vs. Output Power

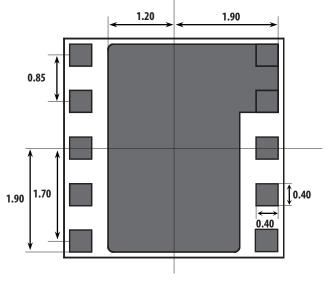
Adjacent Channel Power Ratio 2 vs. Output Power



Power Added Efficiency vs. Output Power

Footprint

All dimensions are in millimeter



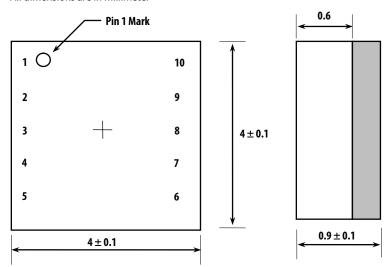
PIN Description

Pin#	Name	Description
1	Ven	PA Enable
2	Vmode	Mode Control
3	Vbp	Bypass Control
4	RFin	RF Input
5	Vcc1	DC Supply Voltage
6	Vcc2	DC Supply Voltage
7	GND	Ground
8	RFout	RF Output
9	GND	Ground
10	GND	Ground

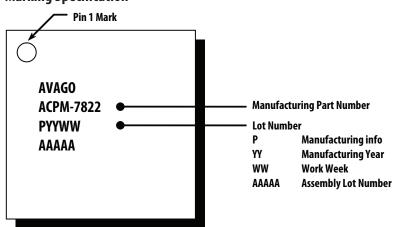
X-RAY TOP VIEW

Package Dimensions

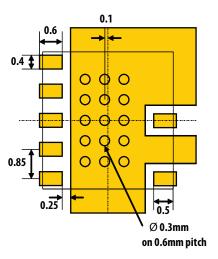
All dimensions are in millimeter



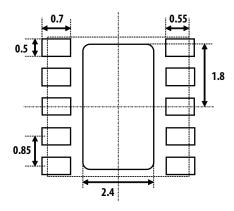
Marking Specification



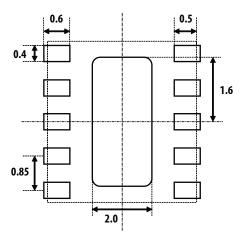
Metallization



Solder Mask Opening



Solder Paste Stencil Aperture



PCB Design Guidelines

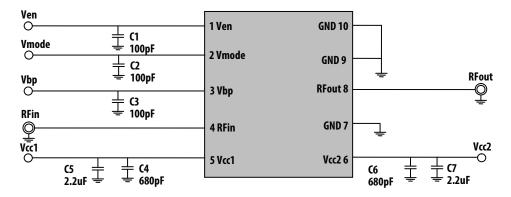
The recommended PCB land pattern is shown in figures on the left side. The substrate is coated with solder mask between the I/O and conductive paddle to protect the gold pads from short circuit that is caused by solder bleeding/bridging.

Stencil Design Guidelines

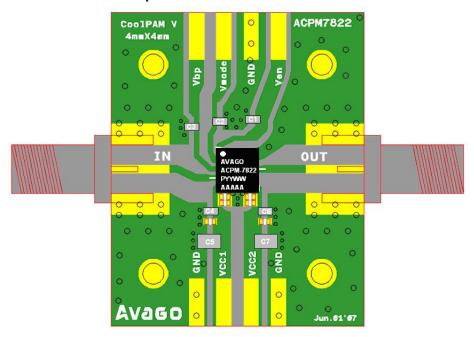
A properly designed solder screen or stencil is required to ensure optimum amount of solder paste is deposited onto the PCB pads.

The recommended stencil layout is shown here. Reducing the stencil opening can potentially generate more voids. On the other hand, stencil openings larger than 100% will lead to excessive solder paste smear or bridging across the I/O pads or conductive paddle to adjacent I/O pads. Considering the fact that solder paste thickness will directly affect the quality of the solder joint, a good choice is to use laser cut stencil composed of 0.100mm(4mils) or 0.127mm(5mils) thick stainless steel which is capable of producing the required fine stencil outline.

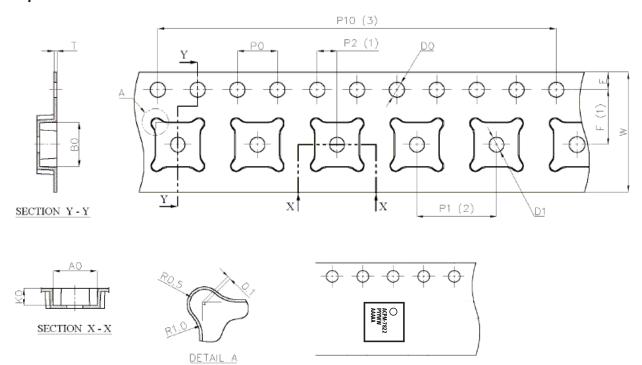
Evaluation Board Schematic



Evaluation Board Description



Tape and Reel Information

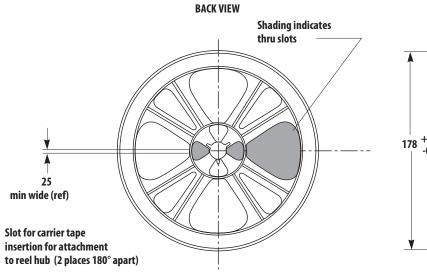


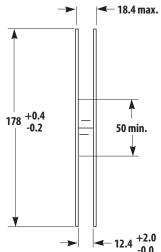
Dimension List

Dimension	Millimeter
A0	4.40±0.10
В0	4.40±0.10
K0	1.70±0.10
D0	1.55±0.05
D1	1.60±0.10
P0	4.00±0.10
P1	8.00±0.10

Dimension	Millimeter
P2	2.00±0.05
P10	40.00±0.20
Е	1.75±0.10
F	5.50±0.05
W	12.00±0.30
Т	0.30±0.05

Reel Drawing





FRONT VIEW 1.5 min. 13.0 ± 0.2 21.0 ± 0.8

Plastic Reel Format (all dimensions are in millimeters)

NOTES:

- 1. Reel shall be labeled with the following information (as a minimum).
 - a. manufacturers name or symbol
 - b. Avago Technologies part number
 - c. purchase order number
 - d. date code
 - e. quantity of units
- A certificate of compliance (c of c) shall be issued and accompany each shipment of product.
- 3. Reel must not be made with or contain ozone depleting materials.
- 4. All dimensions in millimeters (mm)

Handling and Storage

ESD (Electrostatic Discharge)

Electrostatic discharge occurs **naturally in the environ**ment. With the increase in voltage potential, the outlet of neutralization or discharge will be sought. If the acquired discharge route is **through a semiconductor device**, **de**-structive damage will result.

ESD countermeasure methods should be developed and used to control potential ESD damage during handling in a factory environment at each manufacturing site.

MSL (Moisture Sensitivity Level)

Plastic encapsulated surface mount package is sensitive to damage induced by absorbed moisture and temperature.

Avago Technologies follows JEDEC Standard J-STD 020B. Each component and package type is classified for moisture sensitivity by soaking a known dry package at various temperatures and relative humidity, and times.

After soak, the components are subjected to three consecutive simulated reflows.

The out of bag exposure time maximum limits are determined by the classification test describe below which corresponds to a MSL classification level 6 to 1 according to the JEDEC standard IPC/JEDEC J-STD-020B and J-STD-033.

ACPM-7822 is MSL3. Thus, according to the J-STD-033 p.11 the maximum Manufacturers Exposure Time (MET) for this part is 168 hours. After this time period, the part would need to be removed from the reel, de-taped and then re-baked. MSL classification reflow temperature for the ACPM-7822 is targeted at 260°C +0/-5°C. Figure and table on next page show typical SMT profile for maximum temperature of 260 +0/-5°C.

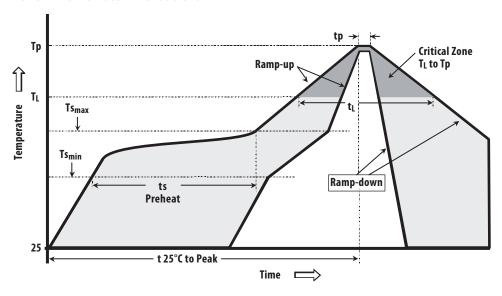
Moisture Classification Level and Floor Life

MSL Level	Floor Life (out of bag) at factory ambient =< 30°C/60% RH or as stated
1	Unlimited at =< 30°C/85% RH
2	1 year
2a	4 weeks
3	168 hours
4	72 hours
5	48 hours
5a	24 hours
6	Mandatory bake before use. After bake, must be reflowed within the time limit specified on the label

Note:

^{1.} The MSL Level is marked on the MSL Label on each shipping bag.

Reflow Profile Recommendations



Typical SMT Reflow Profile for Maximum Temperature = 260 + 0/-5°C

Profile Feature	Sn-Pb Solder	Pb-Free Solder
Average ramp-up rate (TL to TP)	3°C/sec max	3°C/sec max
Preheat - Temperature Min (Tsmin) - Temperature Max (Tsmax) - Time (min to max) (ts)	100°C 150°C 60-120 sec	150°C 200°C 60-180 sec
Tsmax to TL - Ramp-up Rate		3°C/sec max
Time maintained above: – Temperature (TL) – Time (TL)	183°C 60-150 sec	217°C 60-150 sec
Peak temperature (Tp)	240 +0/-5°C	260 +0/-5°C
Time within 5°C of actual Peak Temperature (tp)	10-30 sec	20-40 sec
Ramp-down Rate	6°C/sec max	6°C/sec max
Time 25°C to Peak Temperature	6 min max.	8 min max.

Typical SMT Reflow Profile for Maximum Temperature = 260 + 0/-5°C

Storage Condition

Packages described in this document must be stored in sealed moisture barrier, antistatic bags. Shelf life in a sealed moisture barrier bag is 12 months at <40°C and 90% relative humidity (RH) J-STD-033 p.7.

Out-of-Bag Time Duration

After unpacking the device must be soldered to the PCB within 168 hours as listed in the J-STD-020B p.11 with factory conditions <30°C and 60% RH.

Baking

It is not necessary to re-bake the part if both conditions (storage conditions and out-of bag conditions) have been satisfied. Baking must be done if at least one of the conditions above have not been satisfied. The baking conditions are 125°C for 12 hours J-STD-033 p.8.

CAUTION

Tape and reel materials typically cannot be baked at the temperature described above. If out-of-bag exposure time is exceeded, parts must be baked for a longer time at low temperatures, or the parts must be de-reeled, de-taped, re-baked and then put back on tape and reel. (See moisture sensitive warning label on each shipping bag for information of baking).

Board Rework Component Removal, Rework and Remount

If a component is to be removed from the board, it is recommended that localized heating be used and the maximum body temperatures of any surface mount component on the board not exceed 200°C. This method will minimize moisture related component damage. If any component temperature exceeds 200°C, the board must be baked dry per 4-2 prior to rework and/or component removal. Component temperatures shall be measured at the top center of the package body. Any SMD packages that have not exceeded their floor life can be exposed to a maximum body temperature as high as their specified maximum reflow temperature.

Removal for Failure Analysis

Not following the above requirements may cause moisture/ reflow damage that could hinder or completely prevent the determination of the original failure mechanism.

Baking of Populated Boards

Some SMD packages and board materials are not able to withstand long duration bakes at 125°C. Examples of this are some FR-4 materials, which cannot withstand a 24 hr bake at 125°C. Batteries and electrolytic capacitors are also temperature sensitive. With component and board temperature restrictions in mind, choose a bake temperature from Table 4-1 in J-STD 033; then determine the appropriate bake duration based on the component to be removed. For additional considerations see IPC-7711 and IPC-7721.

Derating due to Factory Environmental Conditions

Factory floor life exposures for SMD packages removed from the dry bags will be a function of the ambient environmental conditions. A safe, yet conservative, handling approach is to expose the SMD packages only up to the maximum time limits for each moisture sensitivity level as shown in next table. This approach, however, does not work if the factory humidity or temperature is greater than the testing conditions of 30°C/60% RH. A solution for addressing this problem is to derate the exposure times based on the knowledge of moisture diffusion in the component package materials ref. JESD22-A120). Recommended equivalent total floor life exposures can be estimated for a range of humidities and temperatures based on the nominal plastic thickness for each device.

Table on next page lists equivalent derated floor lives for humidities ranging from 20-90% RH for three temperature, 20°C, 25°C, and 30°C.

Table on next page is applicable to SMDs molded with novolac, biphenyl or multifunctional epoxy mold compounds. The following assumptions were used in calculating this table:

- 1. Activation Energy for diffusion = 0.35eV (smallest known value).
- 2. For ≤60% RH, use Diffusivity = 0.121exp (-0.35eV/kT) mm2/s (this used smallest known Diffusivity @ 30°C).
- 3. For >60% RH, use Diffusivity = 1.320exp (-0.35eV/kT) mm2/s (this used largest known Diffusivity @ 30°C).

Recommended Equivalent Total Floor Life (days) @ 20°C, 25°C & 30°C For ICs with Novolac, Biphenyl and Multifunctional Epoxies (Reflow at same temperature at which the component was classified)

Maximum Percent Relative Hu	midity											
Package Type and Body Thickness	Moisture Sensitiv- ity Level	5%	10%	20%	30%	40%	50%	60%	70%	80%	90%	
Body Thickness ≥3.1 mm	Level 2a	∞	∞	∞	60	41	33	28	10	7	6	30°C
ncluding PQFPs >84 pin,		∞	∞	∞	78	53	42	36	14	10	8	25°C
PLCCs (square)		∞	∞	∞	103	69	57	47	19	13	10	20°C
All MQFPs	Level 3	∞	∞	10	9	8	7	7	5	4	4	30°C
or		∞	∞	13	11	10	9	9	7	6	5	25°C
All BGAs ≥1 mm		∞	∞	17	14	13	12	12	10	8	7	20°C
	Level 4	∞	5	4	4	4	3	3	3	2	2	30°C
		∞	6	5	5	5	5	4	3	3	3	25°C
		∞	8	7	7	7	7	6	5	4	4	20°C
	Level 5	∞	4	3	3	2	2	2	2	1	1	30°C
		∞	5	5	4	4	3	3	2	2	2	25°C
		∞	7	7	6	5	5	4	3	2	3	20°C
	Level 5a	∞	2	1	1	1	1	1	1	1	1	30°C
		∞	3	2	2	2	2	2	1	1	1	25°C
		∞	5	4	3	3	3	2	2	2	2	20°C
Body 2.1 mm ≤ Thickness	Level 2a	∞	∞	∞	∞	86	39	28	4	3	2	30°C
<3.1 mm including		∞	∞	∞	∞	148	51	37	6	4	3	25°C
PLCCs (rectangular)		∞	∞	∞	∞	∞	69	49	8	5	4	20°C
18-32 pin	Level 3	∞	∞	19	12	9	8	7	3	2	2	30°C
SOICs (wide body)		∞	∞	25	15	12	10	9	5	3	3	25°C
SOICs ≥20 pins, PQFPs ≤80 pins		∞	∞	32	19	15	13	12	7	5	4	20°C
r Qi r s 200 pii is	Level 4	∞	7	5	4	4	3	3	2	2	1	30°C
		∞	9	7	5	5	4	4	3	2	2	25°C
		∞	11	9	7	6	6	5	4	3	3	20°C
	Level 5	∞	4	3	3	2	2	2	1	1	1	30°C
		∞	5	4	3	3	3	3	2	1	1	25°C
		∞	6	5	5	4	4	4	3	3	2	20°C
	Level 5a	∞	2	1	1	1	1	1	1	0.5	0.5	30°C
		∞	2	2	2	2	2	2	1	1	1	25°C
		∞	3	2	2	2	2	2	2	2	1	20°C
Body Thickness <2.1 mm	Level 2a	∞	∞	∞	∞	∞	∞	28	1	1	1	30°C
including SOICs <18 pin		∞	∞	∞	∞	∞	∞	∞	2	1	1	25°C
All TQFPs, TSOPs		∞	∞	∞	∞	∞	∞	∞	2	2	1	20°C
or	Level 3	∞	∞	∞	∞	∞	11	7	1	1	1	30°C
All BGAs <1 mm body		∞	∞	∞	∞	∞	14	10	2	1	1	25°C
thickness		∞	∞	∞	∞	∞	20	13	2	2	1	20°C
	Level 4	∞	∞	∞	9	5	4	3	1	1	1	30°C
		∞	∞	∞	12	7	5	4	2	1	1	25°C
		∞	∞	∞	17	9	7	6	2	2	1	20°C
	Level 5	∞	∞	13	5	3	2	2	1	1	1	30°C
		∞	∞	18	6	4	3	3	2	1	1	25°C
		∞	∞	26	8	6	5	4	2	2	1	20°C
	Level 5a	∞	10	3	2	1	1	1	1	1	0.5	30°C
		∞	13	5	3	2	2	2	1	1	1	25°C
		∞	18	6	4	3	2	2	2	2	1	20°C

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